

74AC/ACT11273

Octal D-Type Flip-Flop with Reset

Objective Specification

ACL Products

FEATURES

- Eight edge-triggered D-type flip-flops
- Buffered common clock
- Buffered, asynchronous Master Reset
- Output capability: ± 24 mA
- CMOS (AC) and TTL (ACT) voltage level inputs
- 50 Ω incident wave switching
- Center-pin V_{CC} and ground configuration to minimize high-speed switching noise
- I_{CC} category: MSI

DESCRIPTION

The 74AC/ACT11273 high-performance CMOS devices combine very high speed and high output drive comparable to the most advanced TTL families.

The 74AC/ACT11273 provides eight positive edge-triggered D-type flip-flops with individual Data inputs and Q outputs. The common buffered Clock (CP) and Master Reset (\overline{MR}) inputs load and reset (clear) all flip-flops simultaneously.

All outputs will be forced Low independently of Clock or Data inputs by a Low voltage level on the MR input. The device

GENERAL INFORMATION

SYMBOL	PARAMETER	CONDITIONS $T_A = 25^\circ\text{C}; \text{GND} = 0\text{V};$ $V_{CC} = 5.0\text{V}$	TYPICAL		UNIT
			AC	ACT	
t_{PLH}/t_{PHL}	Propagation delay CP to Q_n	$C_L = 50\text{pF}$			ns
C_{PD}	Power dissipation capacitance per flip-flop ¹	$f = 1\text{MHz}; C_L = 50\text{pF}$			pF
C_{IN}	Input capacitance	$V_I = 0\text{V}$ or V_{CC}			pF
I_{LATCH}	Latch-up current	Per Jeduc JC40.2 Standard 17			mA
f_{MAX}	Maximum clock frequency	$C_L = 50\text{pF}$			MHz

Note:

1. C_{PD} is used to determine the dynamic power dissipation (P_D in μW):

$$P_D = C_{PD} \times V_{CC}^2 \times f_I + \sum (C_L \times V_{CC}^2 \times f_O) \text{ where:}$$

f_I = input frequency in MHz, C_L = output load capacitance in pF,

f_O = output frequency in MHz, V_{CC} = supply voltage in V,

$\sum (C_L \times V_{CC}^2 \times f_O)$ = sum of outputs

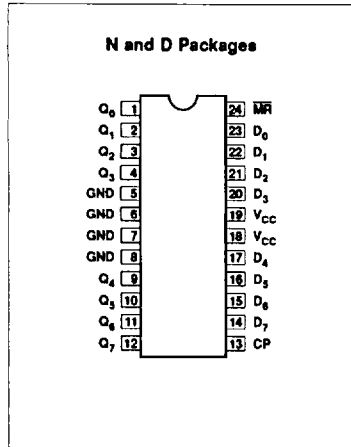
ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	ORDER CODE
24-pin plastic DIP (300mil-wide)	-40°C to +85°C	74AC11273N 74ACT11273N
24-pin plastic SO (300mil-wide)	-40°C to +85°C	74AC11273D 74ACT11273D

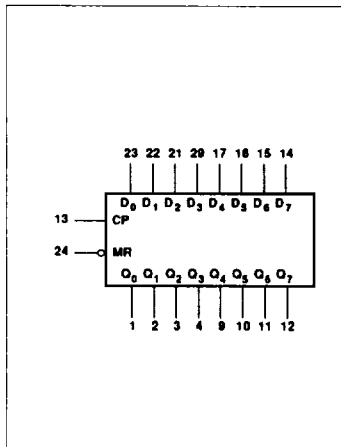
is useful for applications where the true output only is required and the Clock and

Master Reset are common to all storage elements.

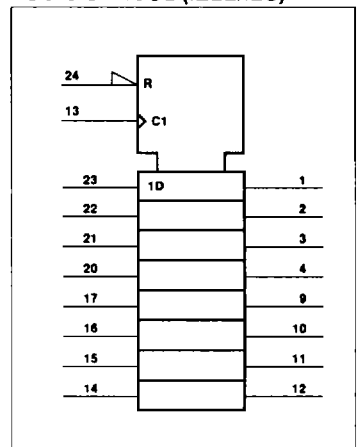
PIN CONFIGURATION



LOGIC SYMBOL



LOGIC SYMBOL (IEEE/IEC)



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PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
24	\overline{MR}	Master reset (active-Low)
13	CP	Clock pulse input
23, 22, 21, 20, 17, 16, 15, 14	$D_0 - D_7$	Data inputs
1, 2, 3, 4, 9, 10, 11, 12	$Q_0 - Q_7$	Data outputs
5, 6, 7, 8	GND	Ground (0V)
18, 19	V_{CC}	Positive supply voltage

MODE SELECT—FUNCTION TABLE

OPERATING MODE	INPUTS			OUTPUTS
	\overline{MR}	CP	D_n	Q_n
Reset (clear)	L	X	X	L
Load "1"	H	↑	h	H
Load "0"	H	↑	l	L

H = High voltage level steady state

h = High voltage level one setup time prior to the Low-to-High clock transition

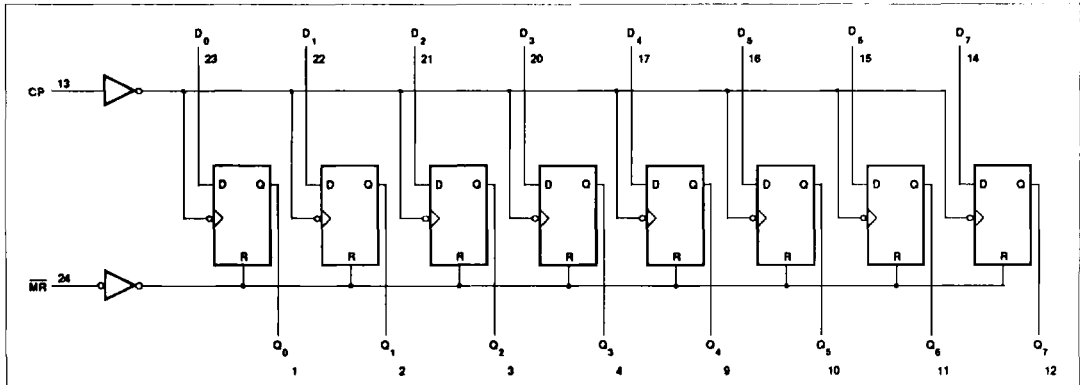
L = Low voltage level steady state

l = Low voltage level one setup time prior to the Low-to-High clock transition

X = Don't care

↑ = Low-to-High clock transition

LOGIC DIAGRAM



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RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	74AC11273			74ACT11273			UNIT
		Min	Nom	Max	Min	Nom	Max	
V_{CC}	DC supply voltage	3.0 ¹	5.0	5.5	4.5	5.0	5.5	V
V_I	Input voltage	0		V_{CC}	0		V_{CC}	V
V_O	Output voltage	0		V_{CC}	0		V_{CC}	V
$\Delta V/\Delta v$	Input transition rise or fall rate	0		10	0		10	ns/V
T_A	Operating free-air temperature	-40		+85	-40		+85	°C

NOTE:

1. No electrical or switching characteristics are specified at $V_{CC} < 3V$. Operation between 2V and 3V is not recommended, but within that range, a device output will maintain a previously established logic state.

ABSOLUTE MAXIMUM RATINGS¹

SYMBOL	PARAMETER	TEST CONDITIONS	RATING	UNIT
V_{CC}	DC supply voltage		-0.5 to +7.0	V
I_{IK} or V_I	DC input diode current ²	$V_I < 0$	-20	mA
		$V_I > V_{CC}$	20	
	DC input voltage		-0.5 to $V_{CC} + 0.5$	V
I_{OK} or V_O	DC output diode current ²	$V_O < 0$	-50	mA
		$V_O > V_{CC}$	50	
	DC output voltage		-0.5 to $V_{CC} + 0.5$	V
I_O	DC output source or sink current per output pin	$V_O = 0$ to V_{CC}	± 50	mA
I_{CC} or I_{GND}	DC V_{CC} current		± 200	mA
	DC ground current		± 200	
T_{STG}	Storage temperature		-65 to 150	°C
P_{TOT}	Power dissipation per package Plastic DIP	Above 70°C derate linearly by 8mW/K	500	mW
	Power dissipation per package Plastic surface mount (SO)	Above 70°C derate linearly by 6mW/K	400	mW

NOTES:

- Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

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DC ELECTRICAL CHARACTERISTICS

SYMBOL	PARAMETER	TEST CONDITIONS	V _{CC}	74AC11273				74ACT11273				UNIT	
				T _A = +25°C		T _A = -40°C to +85°C		T _A = +25°C		T _A = -40°C to +85°C			
				V	Min	Max	Min	Max	Min	Max	Min		Max
V _{IH}	High-level input voltage		3.0	2.10		2.10						V	
			4.5	3.15		3.15		2.0		2.0			
			5.5	3.85		3.85		2.0		2.0			
V _{IL}	Low-level input voltage		3.0		0.90		0.90					V	
			4.5		1.35		1.35		0.8		0.8		
			5.5		1.65		1.65		0.8		0.8		
V _{OH}	High-level output voltage	V _I = V _{IL} or V _{IH}	I _{OH} = -50μA	3.0	2.9		2.9					V	
				4.5	4.4		4.4		4.4		4.4		
				5.5	5.4		5.4		5.4		5.4		
				I _{OH} = -4mA	3.0	2.58		2.48					
					4.5	3.94		3.8		3.94			3.8
I _{OH} = -24mA	3.0												
	4.5	3.94		4.8		4.94		4.8					
I _{OH} = -75mA ¹	3.0			3.85				3.85					
	5.5												
V _{OL}	Low-level output voltage	V _I = V _{IL} or V _{IH}	I _{OL} = 50μA	3.0		0.1		0.1				V	
				4.5		0.1		0.1		0.1	0.1		
				5.5		0.1		0.1		0.1	0.1		
				I _{OL} = 12mA	3.0		0.36		0.44				
					4.5		0.36		0.44		0.36		0.44
I _{OL} = 24mA	3.0												
	4.5		0.36		0.44		0.36	0.44					
I _{OL} = 75mA ¹	3.0				1.65				1.65				
	5.5												
I _I	Input leakage current	V _I = V _{CC} or GND	5.5		±0.1		±1.0		±0.1		±1.0	μA	
I _{CC}	Quiescent supply current	V _I = V _{CC} or GND, I _O = 0	5.5		8.0		8.0		8.0		8.0	μA	
ΔI _{CC}	Supply current, TTL inputs High ²	One input at 3.4V, other inputs at V _{CC} or GND	5.5						0.9		1.0	mA	

NOTES:

- Not more than one output should be tested at a time, and the duration of the test should not exceed 10ms.
- This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0V or V_{CC}.